

## 30V N-Channel Enhancement Mode MOSFET

**VDS= 30V**

RDS(ON), Vgs@ 10V, Ids@ 3.5A &lt;47mΩ

RDS(ON), Vgs@ 4.5V, Ids@ 2.8A &lt;63mΩ

**Features**

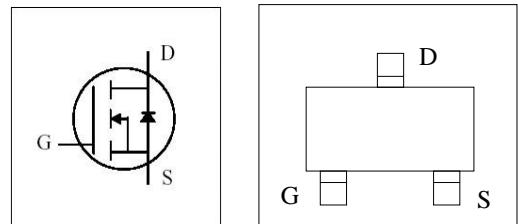
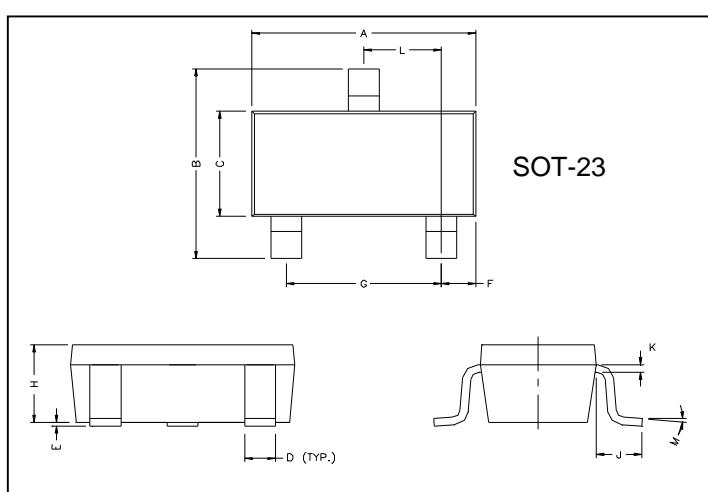
Advanced trench process technology

High Density Cell Design For Ultra Low On-Resistance

High Power and Current handing capability

Ideal for Li ion battery pack applications

## Package Dimensions



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.80	3.00	G	1.80	2.00
B	2.30	2.50	H	0.90	1.1
C	1.20	1.40	K	0.10	0.20
D	0.30	0.50	J	0.35	0.70
E	0	0.10	L	0.92	0.98
F	0.45	0.55	M	0°	10°

- **Absolute Maximum Ratings @TA = 25°C unless otherwise noted**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DSS</sub>	30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	
Drain Current (Note 1)	I <sub>D</sub>	3.5	A
Power Dissipation (Note 1)	P <sub>D</sub>	350	mW
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

Note: 1. Mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch, for each single die.

- Electrical Characteristics @  $T_A = 25^\circ\text{C}$  unless otherwise specified

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS (Note 2)						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	30	35	--	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{DS} = 30V, V_{GS} = 0V$	--	--	1	$\mu\text{A}$
Gate-Body Leakage	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$	--	--	$\pm 100$	nA
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.0		2.5	V
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10V, I_D = 3.5A$ $V_{GS} = 4.5V, I_D = 2.8A$	-- --	30 45	47 63	$\text{m}\Omega$
Forward Transconductance	$G_{FS}$	$V_{DS} = 10V, I_D = 6A$	--	5	--	S
DYNAMIC CHARACTERISTICS						
Input Capacitance	$C_{ISS}$	$V_{DS} = 8V, V_{GS} = 0V$ $F = 1.0\text{MHz}$	--	562	--	pF
Output Capacitance	$C_{OSS}$		--	106	--	
Reverse Transfer Capacitance	$C_{RSS}$		--	75	--	
Total Gate Charge	$Q_G$	$V_{DS} = 10V, I_D = 6A,$ $V_{GS} = 4.5V$	--	4.86	--	nC
Gate-Source Charge	$Q_{GS}$		--	0.92	--	
Gate-Drain	$Q_{GD}$		--	1.4	--	
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$T_{D(\text{ON})}$	$V_{DD} = 10V, I_D = 1A,$ $V_{GEN} = 4.5V, R_G = 6\Omega$	--	18	--	ns
Turn-Off Delay Time	$T_{D(\text{OFF})}$		--	25	--	

Note: 2. Short duration test pulse used to minimize self-heating effect.

- Typical Performance Characteristics

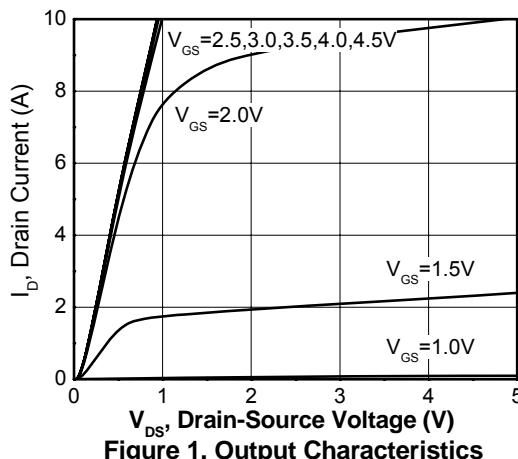


Figure 1. Output Characteristics

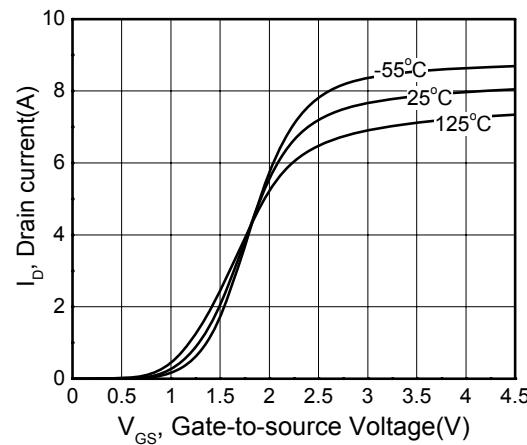
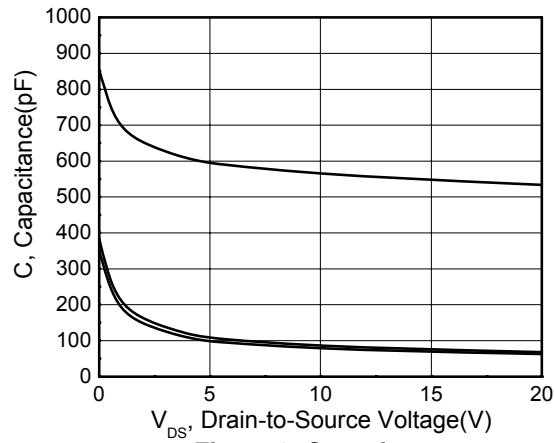
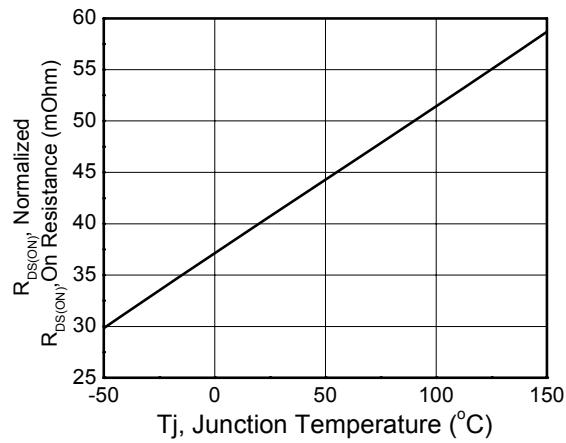
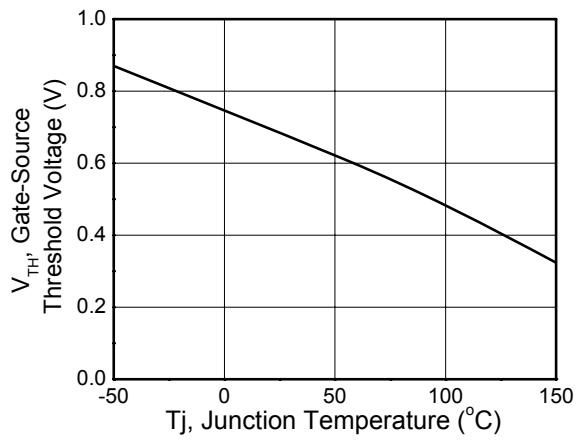
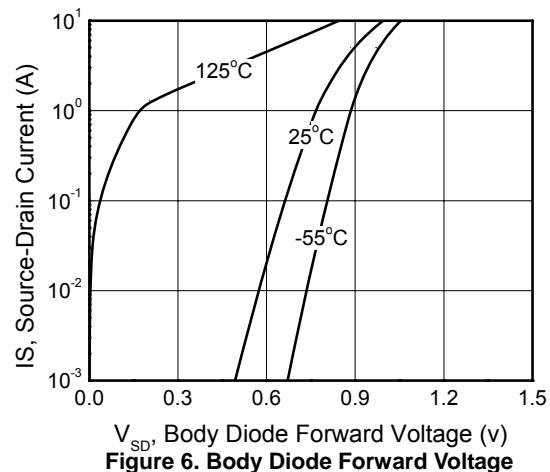


Figure 2. Transfer Characteristics

**Figure 3. Capacitance****Figure 4. On Resistance Vs. Temperature****Figure 5. Gate Thersholt Vs. Temperature****Figure 6. Body Diode Forward Voltage  
Vs. Source Current**

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